Notice of References Cited Application/Control No. 10/786,137 Examiner Andrew Hwa S. Lee Applicant(s)/Patent Under Reexamination HYUN ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,888,627 B2	05-2005	Leslie et al.	356/237.2
*	В	US-6,760,100	07-2004	Ivakhnenko et al.	356/237.2
*	C	US-6,897,957	05-2005	Meeks, Steven W.	356/430
*	D	US-6,411,377	06-2002	Noguchi et al.	356/237.4
	E	US-			
	F	US-			
	G	US-			
	Н	US- «			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Ρ					
	a					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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